

<b>Notice of References Cited</b>	Application/Control No. 10/580,270		Applicant(s)/Patent Under Reexamination TAKEBE, HIROYUKI	
	Examiner PING Y. HSIEH		Art Unit 2618	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0044320 A1	11-2001	Ono et al.	455/550
	B	US-			
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	D	US-			
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